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/ Ruth Montalvo Date: 10/05/04

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**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Docket No. GK-ZEI-3156 / 500343.20157 Confirm No.: 2875  
Applicant(s): Ralf WOLLESCHEMSKY, et al. Allowed: 07/14/04  
Application No.: 10/081,096 Group: 2878  
Filed: February 21, 2002 Examiner: Otilia Gabor  
For: ARRANGEMENT FOR THE OPTICAL CAPTURE OF EXCITED AND/OR  
BACKSCATTERED LIGHT BEAM IN A SAMPLE

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**INFORMATION DISCLOSURE STATEMENT**

S I R:

Applicants wish to make of record the following reference, which was cited in a related patent application:

	Document Number	Date	Name and/or Country
AA	5,329,352	04/12/1994	Jacobsen

Accompanying this Information Disclosure Statement and form PTO-1449 is a copy of the document.

This submission is not an admission that the information disclosed in the documents is material to the patentability of the invention disclosed and/or claimed in the above-identified application.

Respectfully submitted,

  
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Enclosures:  
PTO-1449  
w/document

**LIST OF PRIOR ART CITED BY APPLICANT**  
(Filed on October 5, 2004)Docket No. **GK-ZE1-3156/500343.20157**Applicant(s): **Ralf WOLLECHENSKY and Michael KEMPE**Application No. **10/081,096**Group: **2878**Filed: **February 21, 2002**Examiner: **Otilia Gabor****U.S. PATENT DOCUMENTS**

Exam. Init		Document Number	Date	Name	Class	Sub-Class	Filing Date Appropriate
	<b>AA</b>	<b>5,329,352</b>	<b>04/12/1994</b>	<b>Jacobsen</b>			
	<b>AB</b>						
	<b>AC</b>						
	<b>AD</b>						
	<b>AE</b>						
	<b>AF</b>						
	<b>AG</b>						
	<b>AH</b>						
	<b>AI</b>						
	<b>AJ</b>						
	<b>AK</b>						

**FOREIGN PATENT DOCUMENTS**

		Document Number	Date	Country	CLASS	Sub-Class	Translation YES	NO
	<b>AL</b>							
	<b>AM</b>							
	<b>AN</b>							
	<b>AO</b>							
	<b>AP</b>							
	<b>AQ</b>							
	<b>AR</b>							
	<b>AS</b>							

**OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)**

	<b>AV</b>	
	<b>AW</b>	
	<b>AX</b>	
	<b>AY</b>	
	<b>AZ</b>	

Examiner:

Date:

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.